Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/820,854	CHEN ET AL.	
Examiner	**Art Unit**	
Ben P. Sandvik	2826	

SEARCHED			
Class	Subclass	Date	Examiner
257	686	3/24/2005	BPS
257	738	3/24/2005	BPS
257	706	3/24/2005	BPS
438	109	3/24/2005	BPS
438	122	3/24/2005	BPS

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR